

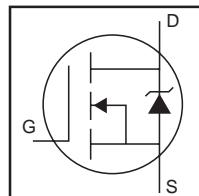
IRFB3307
IRFS3307
IRFSL3307

Applications

- High Efficiency Synchronous Rectification in SMPS
- Uninterruptible Power Supply
- High Speed Power Switching
- Hard Switched and High Frequency Circuits

Benefits

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability



HEXFET® Power MOSFET

| | |
|--------------------------------|--------------|
| V_{DSS} | 75V |
| R_{DS(on)} typ. | 5.0mΩ |
| max. | 6.3mΩ |



Absolute Maximum Ratings

| Symbol | Parameter | Max. | Units |
|---|--|------------------|-------|
| I _D @ T _C = 25°C | Continuous Drain Current, V _{GS} @ 10V | 130① | A |
| I _D @ T _C = 100°C | Continuous Drain Current, V _{GS} @ 10V | 91① | |
| I _{DM} | Pulsed Drain Current ② | 510 | |
| P _D @ T _C = 25°C | Maximum Power Dissipation | 250 | W |
| | Linear Derating Factor | 1.6 | W/°C |
| V _{GS} | Gate-to-Source Voltage | ± 20 | V |
| dv/dt | Peak Diode Recovery ④ | 11 | V/ns |
| T _J | Operating Junction and | -55 to + 175 | °C |
| T _{STG} | Storage Temperature Range | | |
| | Soldering Temperature, for 10 seconds (1.6mm from case) | | |
| | Mounting torque, 6-32 or M3 screw | 300 | |
| | | 10lb·in (1.1N·m) | |

Avalanche Characteristics

| | | | |
|-------------------------------------|---------------------------------|---------------------------|----|
| E _{AS} (Thermally limited) | Single Pulse Avalanche Energy ③ | 270 | mJ |
| I _{AR} | Avalanche Current ① | See Fig. 14, 15, 16a, 16b | A |
| E _{AR} | Repetitive Avalanche Energy ⑤ | | |

Thermal Resistance

| Symbol | Parameter | Typ. | Max. | Units |
|------------------|---|------|------|-------|
| R _{θJC} | Junction-to-Case ⑨ | — | 0.61 | °C/W |
| R _{θCS} | Case-to-Sink, Flat Greased Surface , TO-220 | 0.50 | — | |
| R _{θJA} | Junction-to-Ambient, TO-220 ⑨ | — | 62 | |
| R _{θJA} | Junction-to-Ambient (PCB Mount) , D ² Pak ⑧⑨ | — | 40 | |

Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| Symbol | Parameter | Min. | Typ. | Max. | Units | Conditions |
|---|--------------------------------------|------|-------|------|---------------------|--|
| $V_{(\text{BR})\text{DSS}}$ | Drain-to-Source Breakdown Voltage | 75 | — | — | V | $V_{\text{GS}} = 0\text{V}$, $I_D = 250\mu\text{A}$ |
| $\Delta V_{(\text{BR})\text{DSS}}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient | — | 0.069 | — | V/ $^\circ\text{C}$ | Reference to 25°C , $I_D = 1\text{mA}$ ② |
| $R_{\text{DS}(\text{on})}$ | Static Drain-to-Source On-Resistance | — | 5.0 | 6.3 | $\text{m}\Omega$ | $V_{\text{GS}} = 10\text{V}$, $I_D = 75\text{A}$ ⑤ |
| $V_{\text{GS}(\text{th})}$ | Gate Threshold Voltage | 2.0 | — | 4.0 | V | $V_{\text{DS}} = V_{\text{GS}}$, $I_D = 150\mu\text{A}$ |
| I_{DSS} | Drain-to-Source Leakage Current | — | — | 20 | μA | $V_{\text{DS}} = 75\text{V}$, $V_{\text{GS}} = 0\text{V}$ |
| | | — | — | 250 | — | $V_{\text{DS}} = 75\text{V}$, $V_{\text{GS}} = 0\text{V}$, $T_J = 125^\circ\text{C}$ |
| I_{GSS} | Gate-to-Source Forward Leakage | — | — | 200 | nA | $V_{\text{GS}} = 20\text{V}$ |
| | Gate-to-Source Reverse Leakage | — | — | -200 | — | $V_{\text{GS}} = -20\text{V}$ |
| R_G | Gate Input Resistance | — | 1.5 | — | Ω | $f = 1\text{MHz}$, open drain |

Dynamic @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

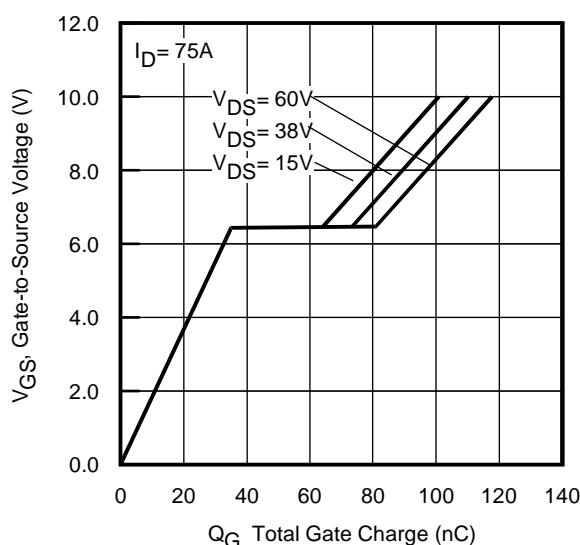
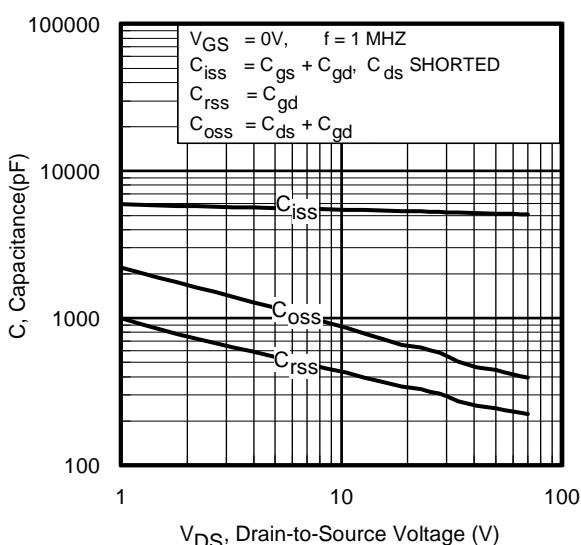
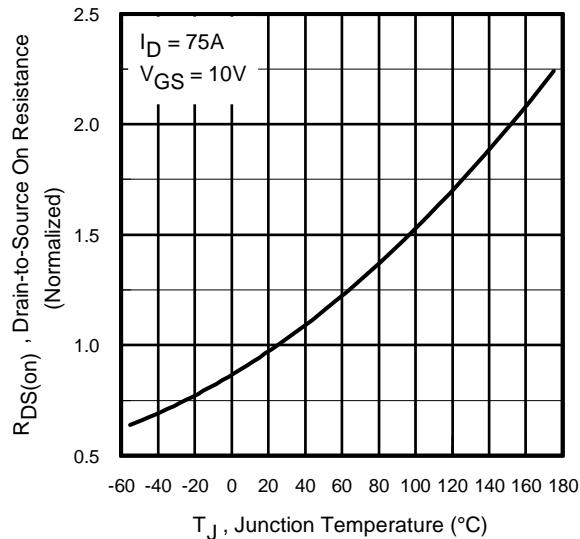
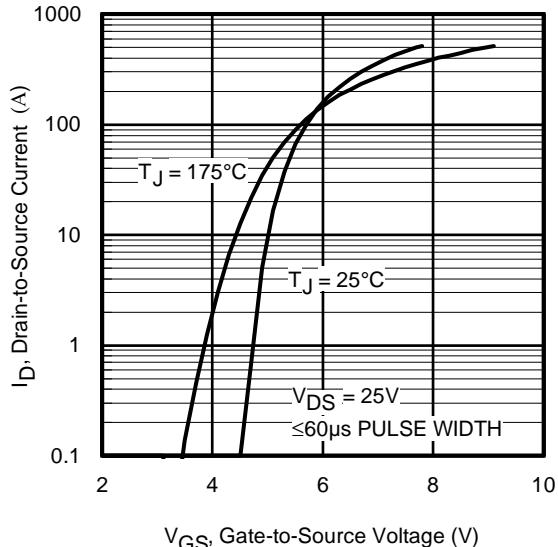
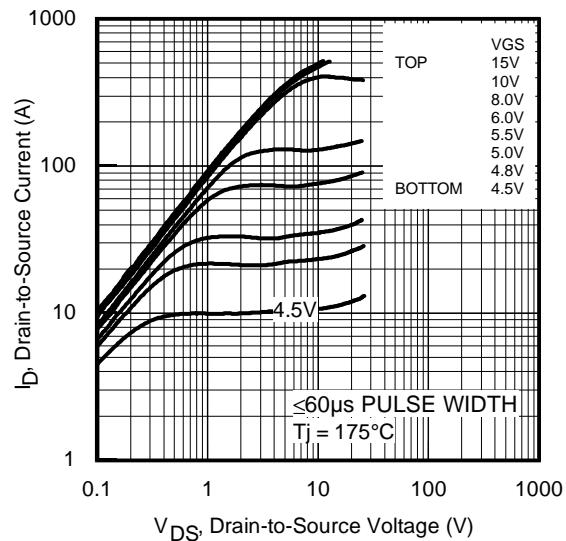
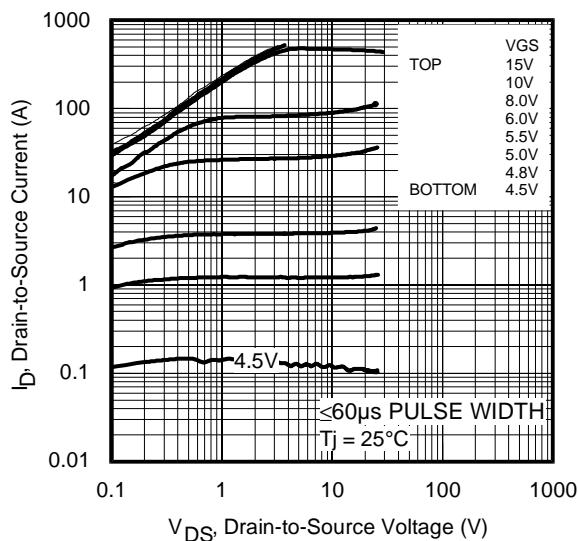
| Symbol | Parameter | Min. | Typ. | Max. | Units | Conditions |
|----------------------------|---|------|------|------|-------|---|
| g_{fs} | Forward Transconductance | 98 | — | — | S | $V_{\text{DS}} = 50\text{V}$, $I_D = 75\text{A}$ |
| Q_g | Total Gate Charge | — | 120 | 180 | nC | $I_D = 75\text{A}$ |
| Q_{gs} | Gate-to-Source Charge | — | 35 | — | — | $V_{\text{DS}} = 60\text{V}$ |
| Q_{gd} | Gate-to-Drain ("Miller") Charge | — | 46 | — | — | $V_{\text{GS}} = 10\text{V}$ ⑤ |
| $t_{\text{d}(\text{on})}$ | Turn-On Delay Time | — | 26 | — | ns | $V_{\text{DD}} = 48\text{V}$ |
| t_r | Rise Time | — | 120 | — | — | $I_D = 75\text{A}$ |
| $t_{\text{d}(\text{off})}$ | Turn-Off Delay Time | — | 51 | — | — | $R_G = 3.9\Omega$ |
| t_f | Fall Time | — | 63 | — | — | $V_{\text{GS}} = 10\text{V}$ ⑤ |
| C_{iss} | Input Capacitance | — | 5150 | — | pF | $V_{\text{GS}} = 0\text{V}$ |
| C_{oss} | Output Capacitance | — | 460 | — | — | $V_{\text{DS}} = 50\text{V}$ |
| C_{rss} | Reverse Transfer Capacitance | — | 250 | — | — | $f = 1.0\text{MHz}$ |
| $C_{\text{oss eff. (ER)}}$ | Effective Output Capacitance (Energy Related) | — | 570 | — | — | $V_{\text{GS}} = 0\text{V}$, $V_{\text{DS}} = 0\text{V}$ to 60V ⑦, See Fig.11 |
| $C_{\text{oss eff. (TR)}}$ | Effective Output Capacitance (Time Related)⑥ | — | 700 | — | — | $V_{\text{GS}} = 0\text{V}$, $V_{\text{DS}} = 0\text{V}$ to 60V ⑥, See Fig. 5 |

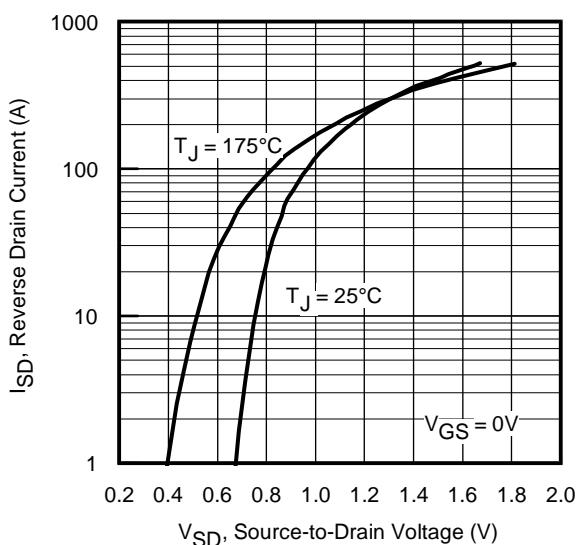
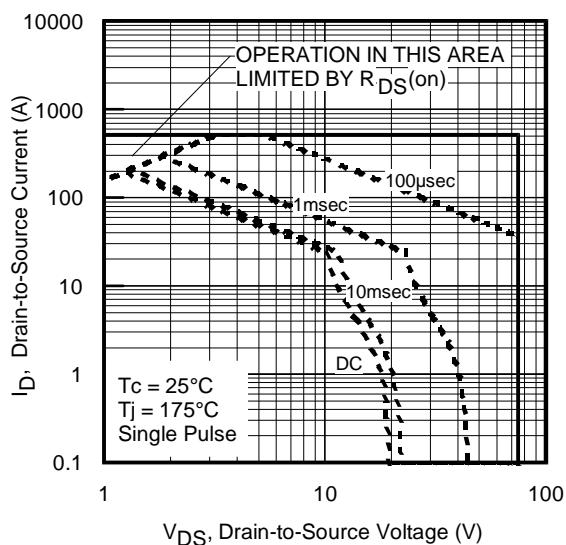
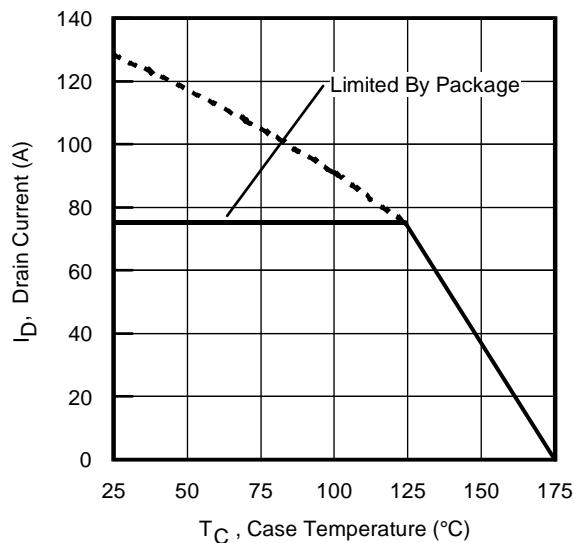
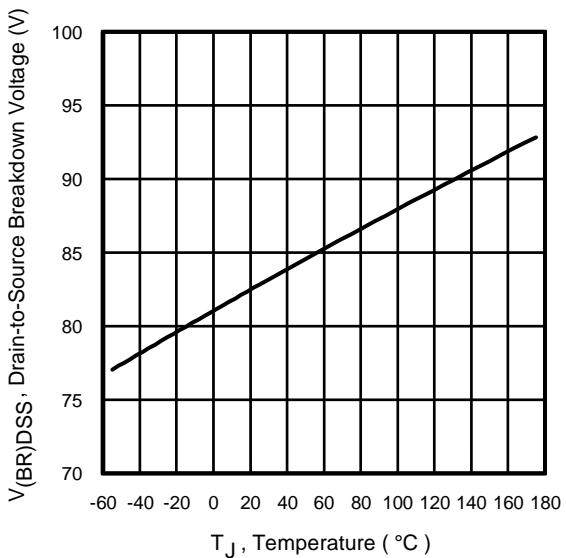
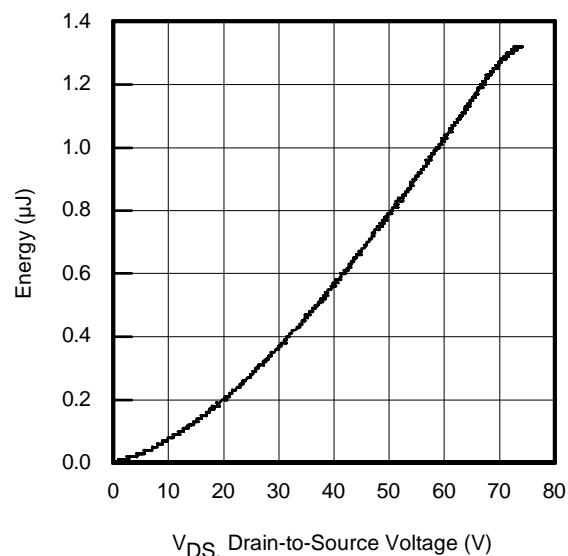
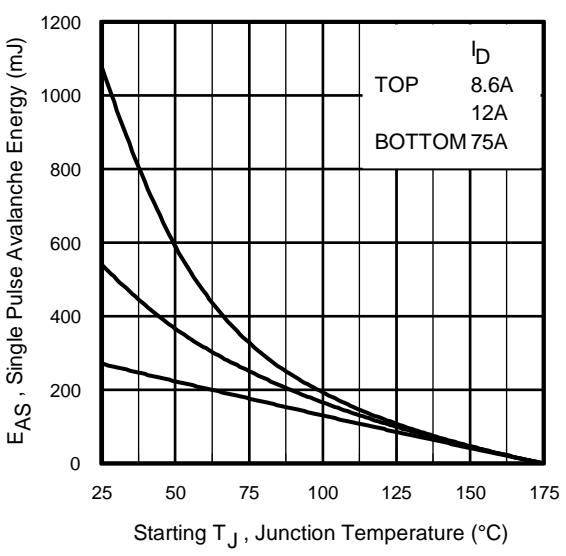
Diode Characteristics

| Symbol | Parameter | Min. | Typ. | Max. | Units | Conditions |
|------------------|--|--|------|------|-------|---|
| I_S | Continuous Source Current (Body Diode) | — | — | 130① | A | MOSFET symbol showing the integral reverse p-n junction diode. |
| I_{SM} | Pulsed Source Current (Body Diode) ② | — | — | 510 | A | — |
| V_{SD} | Diode Forward Voltage | — | — | 1.3 | V | $T_J = 25^\circ\text{C}$, $I_S = 75\text{A}$, $V_{\text{GS}} = 0\text{V}$ ⑤ |
| t_{rr} | Reverse Recovery Time | — | 38 | 57 | ns | $T_J = 25^\circ\text{C}$ $V_R = 64\text{V}$, |
| | | — | 46 | 69 | — | $T_J = 125^\circ\text{C}$ $I_F = 75\text{A}$ |
| Q_{rr} | Reverse Recovery Charge | — | 65 | 98 | nC | $T_J = 25^\circ\text{C}$ $\frac{di}{dt} = 100\text{A}/\mu\text{s}$ ⑤ |
| | | — | 86 | 130 | — | $T_J = 125^\circ\text{C}$ |
| I_{RRM} | Reverse Recovery Current | — | 2.8 | — | A | $T_J = 25^\circ\text{C}$ |
| t_{on} | Forward Turn-On Time | Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD) | | | | |

Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 75A.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ Limited by T_{Jmax} , starting $T_J = 25^\circ\text{C}$, $L = 0.096\text{mH}$ $R_G = 25\Omega$, $I_{AS} = 75\text{A}$, $V_{\text{GS}} = 10\text{V}$. Part not recommended for use above this value.
- ④ $I_{\text{SD}} \leq 75\text{A}$, $\frac{di}{dt} \leq 530\text{A}/\mu\text{s}$, $V_{\text{DD}} \leq V_{(\text{BR})\text{DSS}}$, $T_J \leq 175^\circ\text{C}$.
- ⑤ Pulse width $\leq 400\mu\text{s}$; duty cycle $\leq 2\%$.
- ⑥ $C_{\text{oss eff. (TR)}}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .
- ⑦ $C_{\text{oss eff. (ER)}}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .
- ⑧ When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- ⑨ R_θ is measured at T_J approximately 90°C .



**Fig 7.** Typical Source-Drain Diode Forward Voltage**Fig 8.** Maximum Safe Operating Area**Fig 9.** Maximum Drain Current vs. Case Temperature**Fig 10.** Drain-to-Source Breakdown Voltage**Fig 11.** Typical C_{oss} Stored Energy**Fig 12.** Maximum Avalanche Energy vs. Drain Current

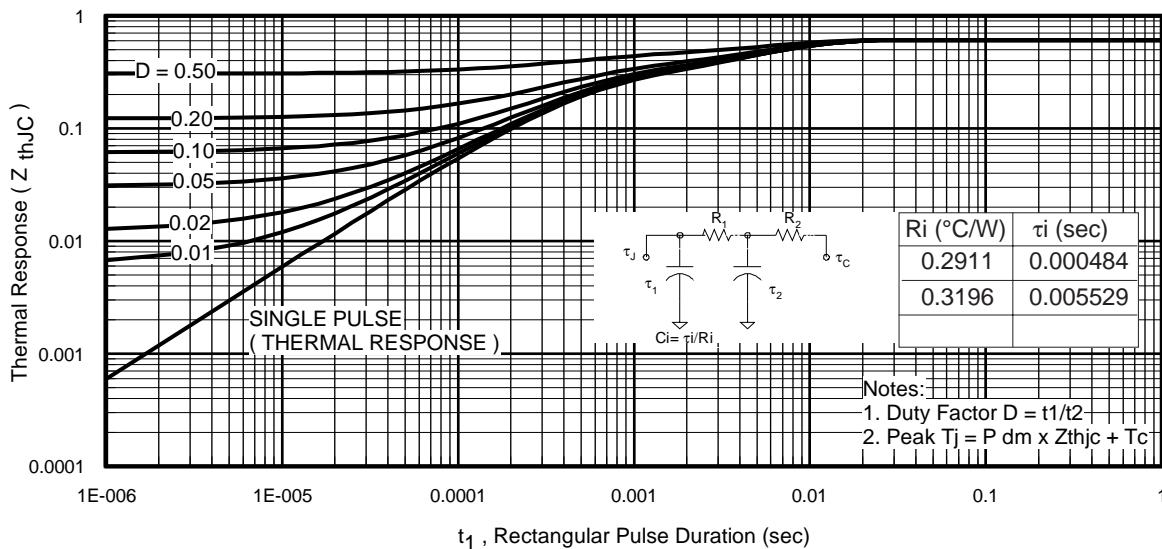


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

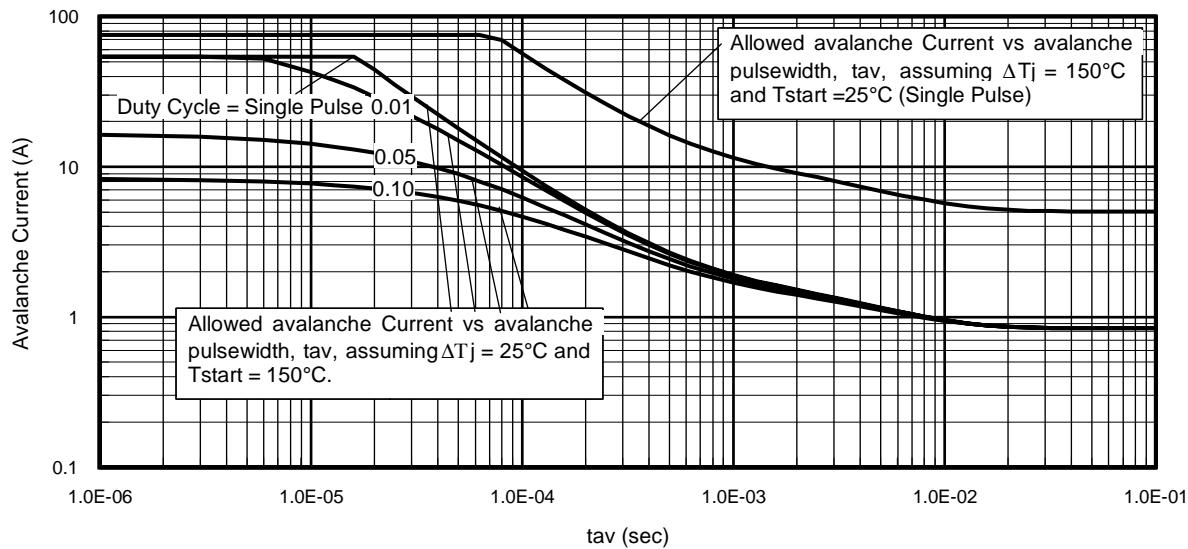


Fig 14. Typical Avalanche Current vs.Pulsewidth

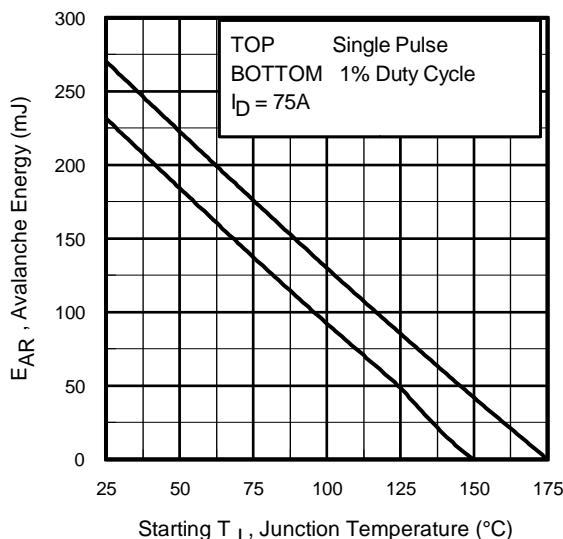


Fig 15. Maximum Avalanche Energy vs. Temperature

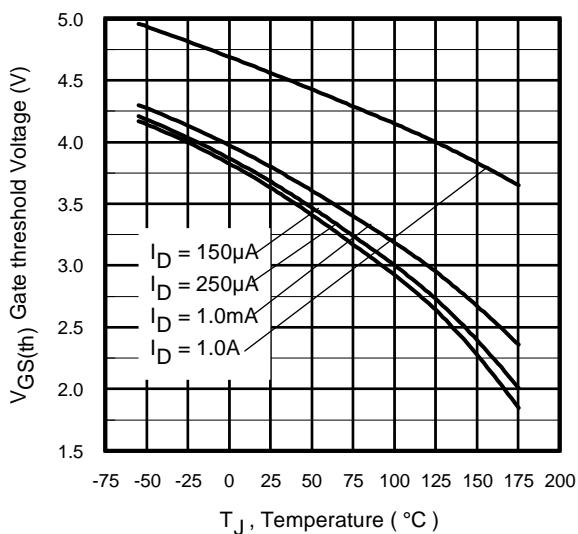
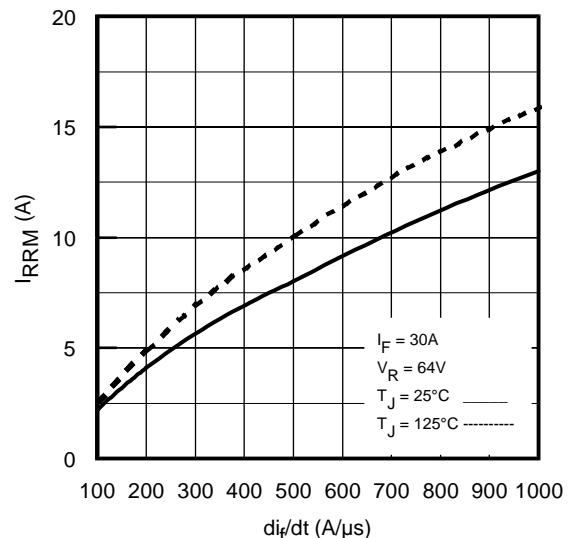
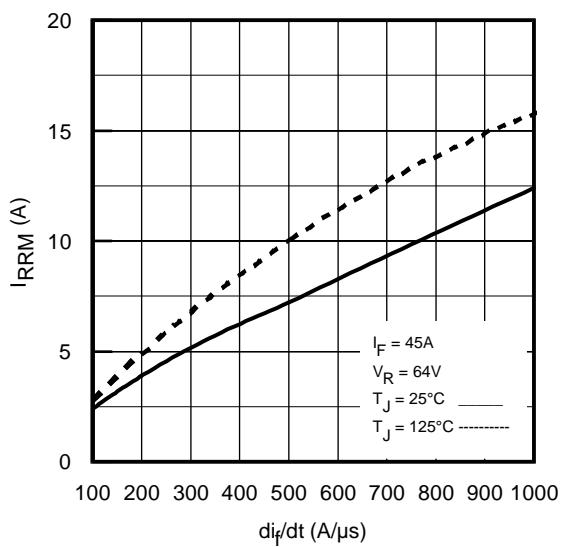
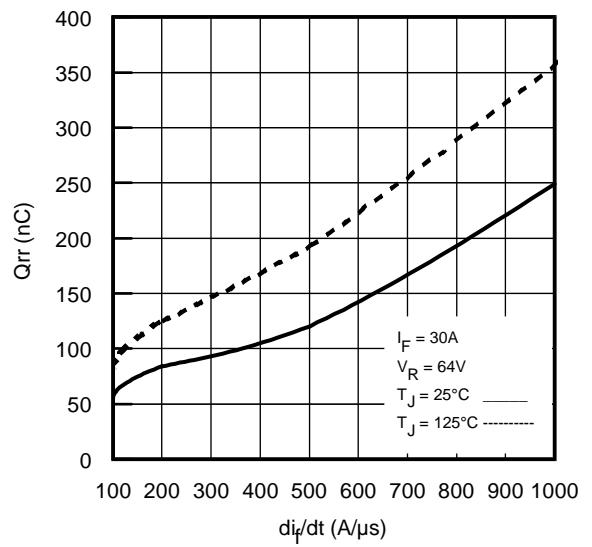
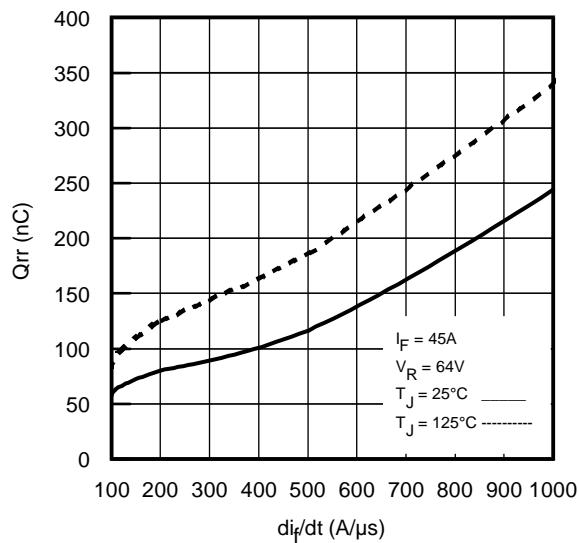
Notes on Repetitive Avalanche Curves , Figures 14, 15:
(For further info, see AN-1005 at www.irf.com)

- Avalanche failures assumption:
Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
- Safe operation in Avalanche is allowed as long as neither T_{jmax} nor I_{av} (max) is exceeded.
- Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- $P_{D(ave)}$ = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- I_{av} = Allowable avalanche current.
- ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).
- t_{av} = Average time in avalanche.
- D = Duty cycle in avalanche = $t_{av} \cdot f$
- $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see Figures 13

$$P_{D(ave)} = 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$$

$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$$

**Fig. 16.** Threshold Voltage vs. Temperature**Fig. 17 -** Typical Recovery Current vs. di_f/dt **Fig. 18 -** Typical Recovery Current vs. di_f/dt **Fig. 19 -** Typical Stored Charge vs. di_f/dt **Fig. 20 -** Typical Stored Charge vs. di_f/dt

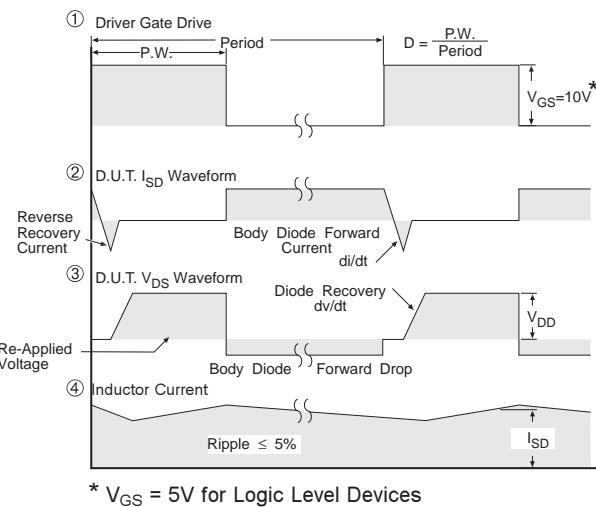
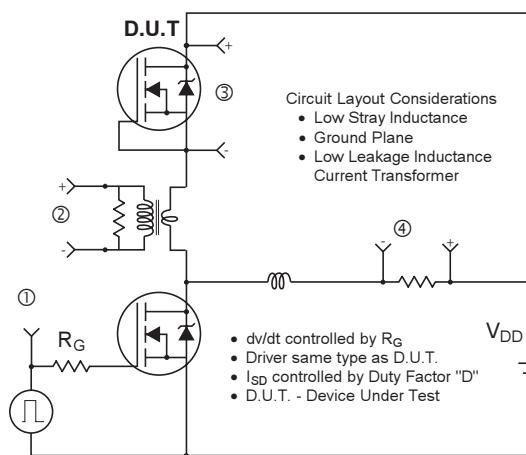


Fig 20. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

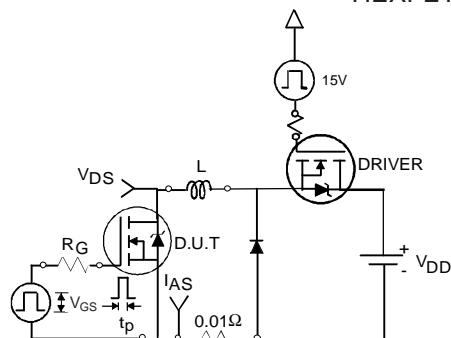


Fig 21a. Unclamped Inductive Test Circuit

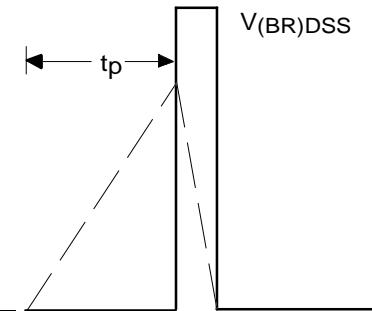


Fig 21b. Unclamped Inductive Waveforms

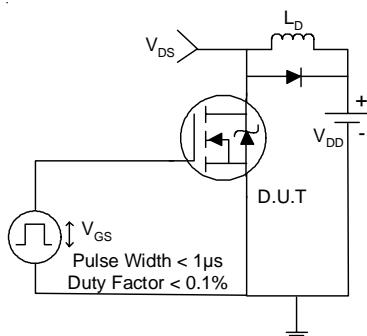


Fig 22a. Switching Time Test Circuit

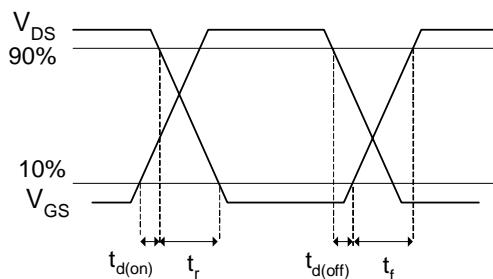


Fig 22b. Switching Time Waveforms

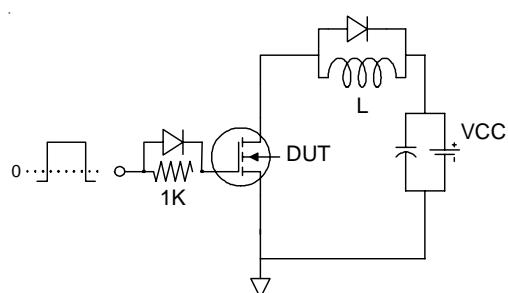


Fig 23a. Gate Charge Test Circuit

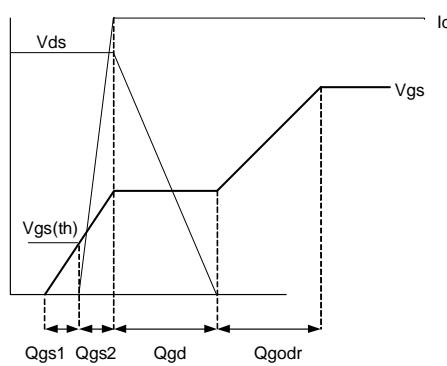
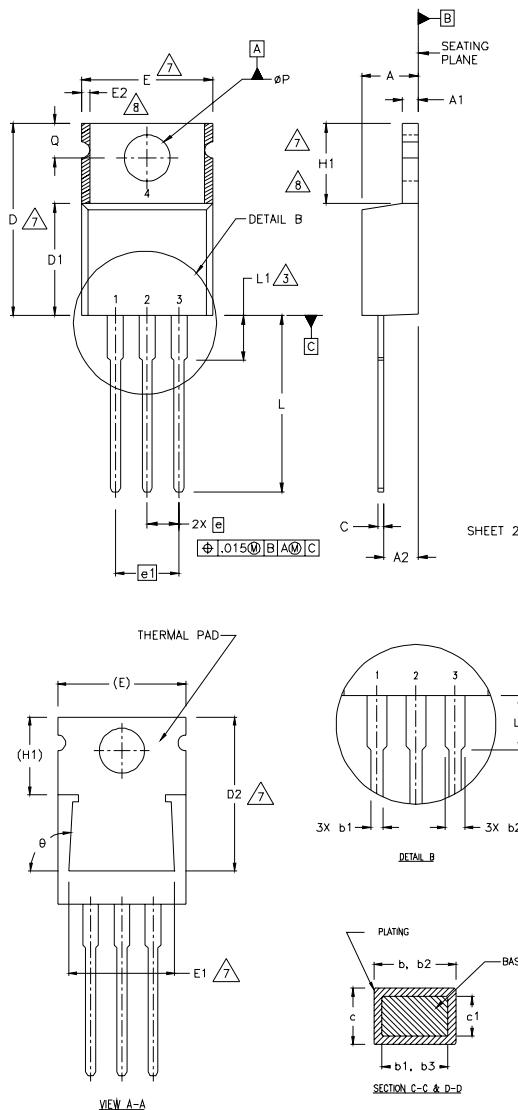


Fig 23b. Gate Charge Waveform

TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



NOTES:

- 1 DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- 2 DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].
- 3 LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.
- 4 DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5 DIMENSION b1 & c1 APPLY TO BASE METAL ONLY.
- 6 CONTROLLING DIMENSION : INCHES.
- 7 THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,02 & E1
- 8 DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRRREGULARITIES ARE ALLOWED.

LEAD ASSIGNMENTS

HEXFET

- 1- GATE
- 2- DRAIN
- 3- SOURCE

IGBTs, Co-PACK

- 1- GATE
- 2- COLLECTOR
- 3- Emitter

DIODES

- 1- ANODE/OPEN
- 2- CATHODE
- 3- ANODE

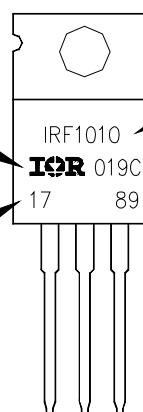
| SYMBOL | DIMENSIONS | | | | NOTES | |
|--------|-------------|-------|----------|------|-------|--|
| | MILLIMETERS | | INCHES | | | |
| | MIN. | MAX. | MIN. | MAX. | | |
| A | 3.56 | 4.82 | .140 | .190 | | |
| A1 | 0.51 | 1.40 | .020 | .055 | | |
| A2 | 2.04 | 2.92 | .080 | .115 | | |
| b | 0.38 | 1.01 | .015 | .040 | | |
| b1 | 0.38 | 0.96 | .015 | .038 | | |
| b2 | 1.15 | 1.77 | .045 | .070 | | |
| b3 | 1.15 | 1.73 | .045 | .068 | | |
| c | 0.36 | 0.61 | .014 | .024 | | |
| c1 | 0.36 | 0.56 | .014 | .022 | 5 | |
| D | 14.22 | 16.51 | .560 | .650 | 4 | |
| D1 | 8.38 | 9.02 | .330 | .355 | | |
| D2 | 12.19 | 12.88 | .480 | .507 | 7 | |
| E | 9.66 | 10.66 | .380 | .420 | 4,7 | |
| E1 | 8.38 | 8.89 | .330 | .350 | 7 | |
| e | 2.54 BSC | | .100 BSC | | | |
| e1 | 5.08 | | .200 BSC | | | |
| H1 | 5.85 | 6.55 | .230 | .270 | 7,8 | |
| L | 12.70 | 14.73 | .500 | .580 | | |
| L1 | - | 6.35 | - | .250 | | |
| ØP | 3.54 | 4.08 | .139 | .161 | | |
| Q | 2.54 | 3.42 | .100 | .135 | | |
| Ø | 90°-93° | | 90°-93° | | | |

TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010
LOT CODE 1789
ASSEMBLED ON WW 19, 2000
IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead - Free"

INTERNATIONAL
RECTIFIER
LOGO
ASSEMBLY
LOT CODE

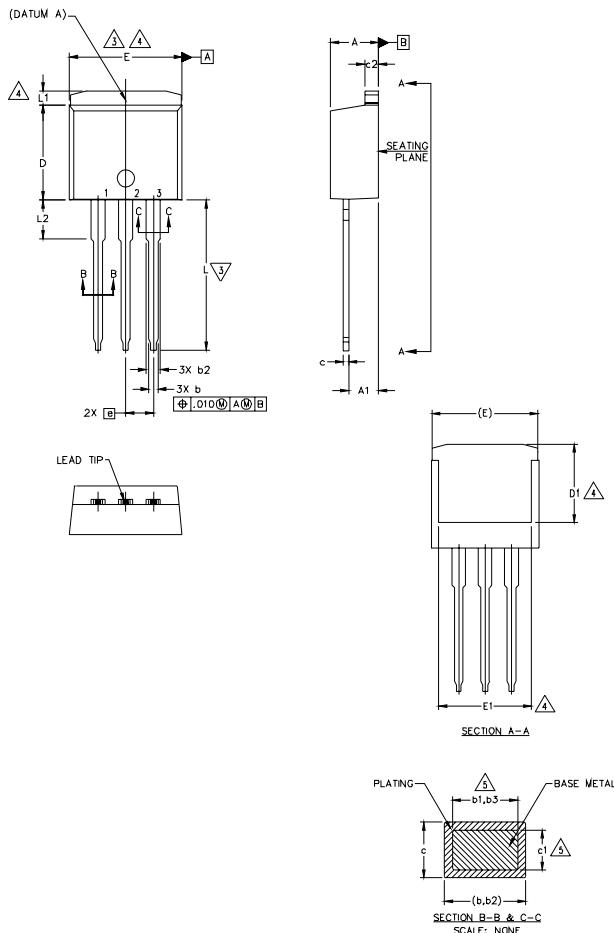


PART NUMBER
DATE CODE
YEAR 0 = 2000
WEEK 19
LINE C

TO-220AB packages are not recommended for Surface Mount Application.

TO-262 Package Outline

Dimensions are shown in millimeters (inches)



NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
5. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
6. CONTROLLING DIMENSION: INCH.
7. OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

| SYMBOL | DIMENSIONS | | | | NOTES | |
|--------|-------------|-------|--------|------|-------|--|
| | MILLIMETERS | | INCHES | | | |
| | MIN. | MAX. | MIN. | MAX. | | |
| A | 4.06 | 4.83 | .160 | .190 | | |
| A1 | 2.03 | 3.02 | .080 | .119 | | |
| b | 0.51 | 0.99 | .020 | .039 | 5 | |
| b1 | 0.51 | 0.89 | .020 | .035 | | |
| b2 | 1.14 | 1.78 | .045 | .070 | | |
| b3 | 1.14 | 1.73 | .045 | .068 | 5 | |
| c | 0.38 | 0.74 | .015 | .029 | | |
| c1 | 0.38 | 0.58 | .015 | .023 | 5 | |
| c2 | 1.14 | 1.65 | .045 | .065 | | |
| D | 8.38 | 9.65 | .330 | .380 | 3 | |
| D1 | 6.86 | — | .270 | — | 4 | |
| E | 9.65 | 10.67 | .380 | .420 | 3,4 | |
| E1 | 6.22 | — | .245 | — | 4 | |
| e | 2.54 | BSC | .100 | BSC | | |
| L | 13.46 | 14.10 | .530 | .555 | | |
| L1 | — | 1.65 | — | .065 | | |
| L2 | 3.56 | 3.71 | .140 | .146 | 4 | |

LEAD ASSIGNMENTS

HEXFET

1. GATE
2. DRAIN
3. SOURCE
4. DRAIN

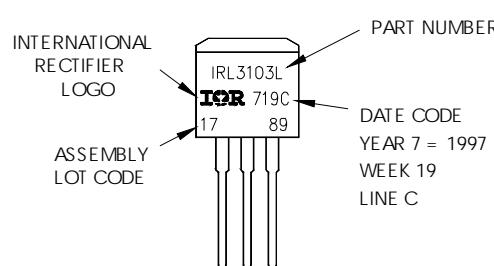
IGBTs, CoPACK

1. GATE
2. COLLECTOR
3. Emitter
4. COLLECTOR

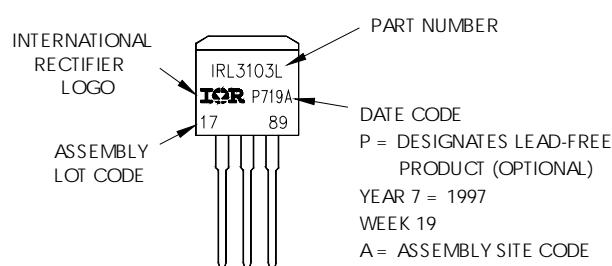
TO-262 Part Marking Information

EXAMPLE: THIS IS AN IRL3103L
LOT CODE 1789
ASSEMBLED ON VW 19, 1997
IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead - Free"

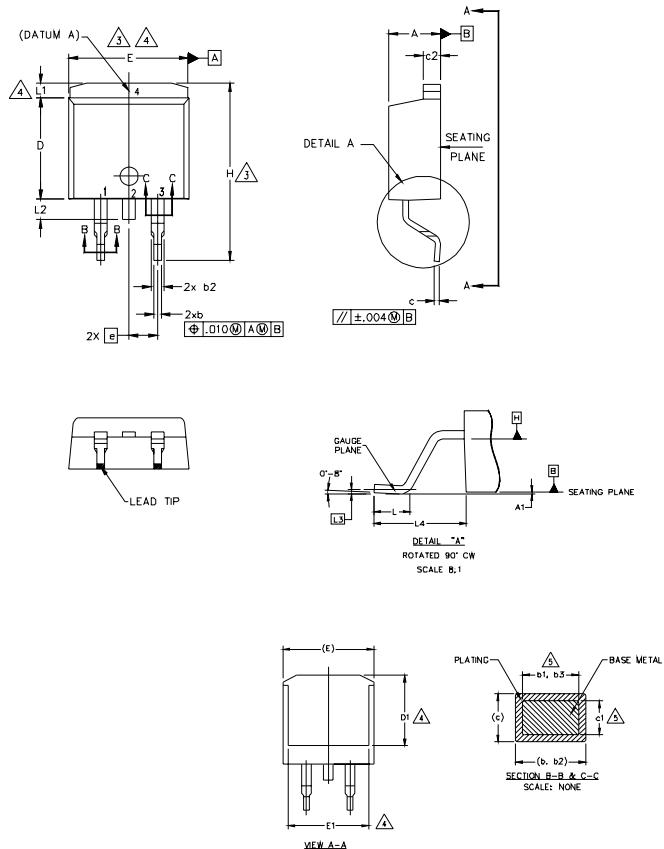


OR



D²Pak (TO-263AB) Package Outline

Dimensions are shown in millimeters (inches)



NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994

2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]

3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.

6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

7. CONTROLLING DIMENSION: INCH.

8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

| SYMBOL | DIMENSIONS | | | | NOTES | |
|--------|-------------|-------|--------|------|-------|--|
| | MILLIMETERS | | INCHES | | | |
| | MIN. | MAX. | MIN. | MAX. | | |
| A | 4.06 | 4.83 | .160 | .190 | | |
| A1 | 0.00 | 0.254 | .000 | .010 | | |
| b | 0.51 | 0.99 | .020 | .039 | | |
| b1 | 0.51 | 0.89 | .020 | .035 | 5 | |
| b2 | 1.14 | 1.78 | .045 | .070 | | |
| b3 | 1.14 | 1.73 | .045 | .068 | 5 | |
| c | 0.38 | 0.74 | .015 | .029 | | |
| c1 | 0.38 | 0.58 | .015 | .023 | 5 | |
| c2 | 1.14 | 1.65 | .045 | .065 | | |
| D | 8.38 | 9.65 | .330 | .380 | 3 | |
| D1 | 6.86 | — | .270 | — | 4 | |
| E | 9.65 | 10.67 | .380 | .420 | 3,4 | |
| E1 | 6.22 | — | .245 | — | 4 | |
| e | 2.54 | BSC | .100 | BSC | | |
| H | 14.61 | 15.88 | .575 | .625 | | |
| L | 1.78 | 2.79 | .070 | .110 | | |
| L1 | — | 1.65 | — | .066 | 4 | |
| L2 | 1.27 | 1.78 | — | .070 | | |
| L3 | 0.25 | BSC | .010 | BSC | | |
| L4 | 4.78 | 5.28 | .188 | .208 | | |

LEAD ASSIGNMENTS

HEXFET

1. GATE
2, 4. DRAIN
3. SOURCE

IGBTs, CoPACK

1. GATE
2, 4. COLLECTOR
3. Emitter

DIODES

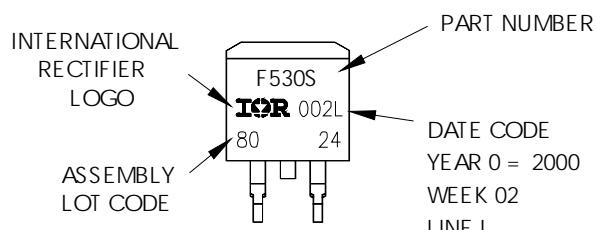
1. ANODE *
2, 4. CATHODE
3. ANODE

* PART DEPENDENT.

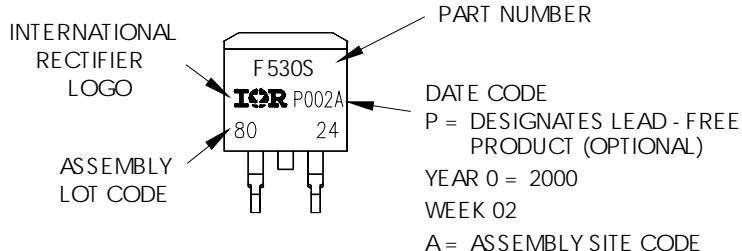
D²Pak (TO-263AB) Part Marking Information

EXAMPLE: THIS IS AN IRF530S WTH
LOT CODE 8024
ASSEMBLED ON WW02, 2000
IN THE ASSEMBLY LINE "L"

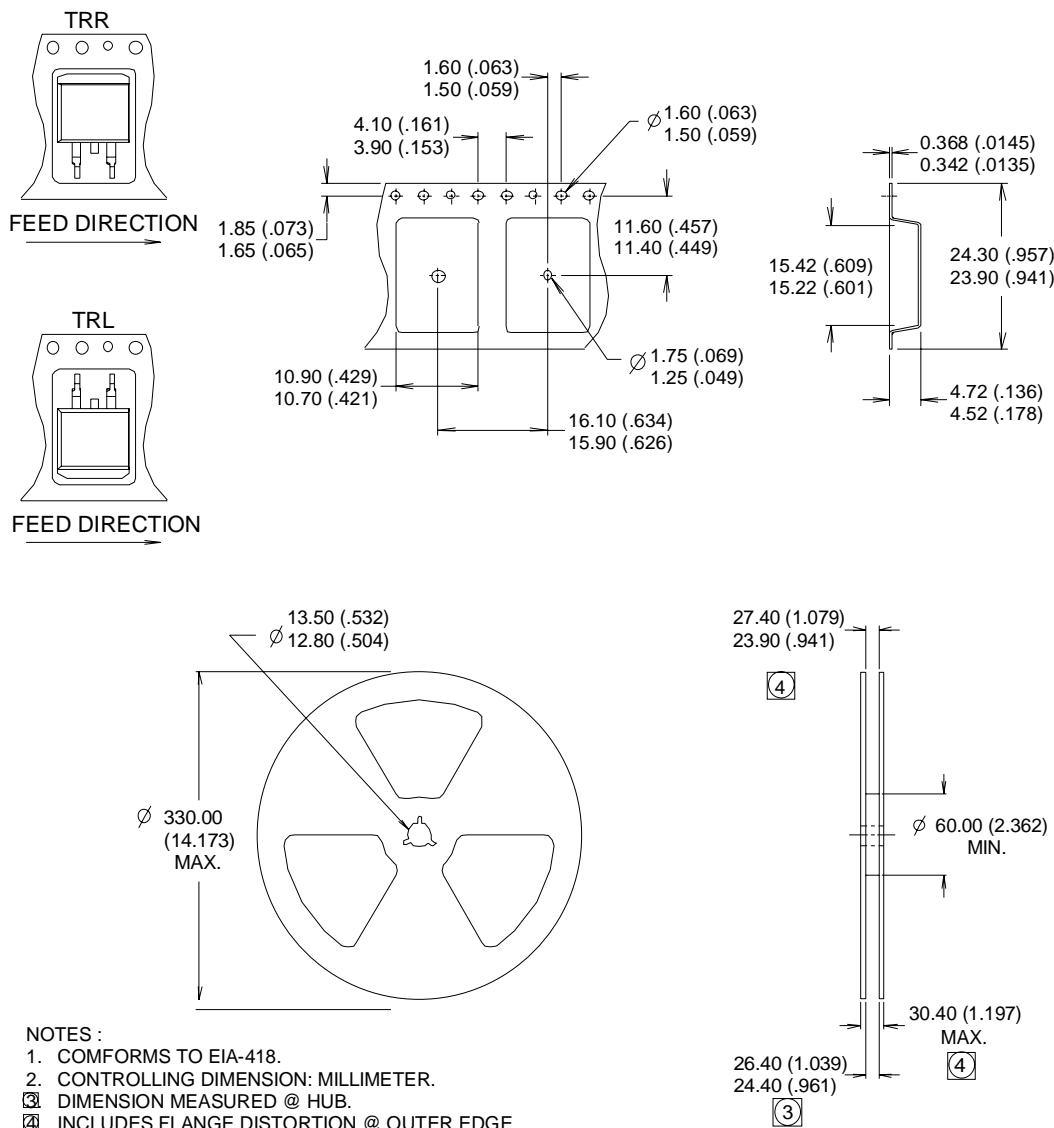
Note: "P" in assembly line position
indicates "Lead - Free"



OR



D²Pak (TO-263AB) Tape & Reel Information



Data and specifications subject to change without notice.
This product has been designed and qualified for the Industrial market.
Qualification Standards can be found on IR's Web site.

International
IR Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105
TAC Fax: (310) 252-7903
Visit us at www.irf.com for sales contact information. 01/06

Note: For the most current drawings please refer to the IR website at:
<http://www.irf.com/package/>